



DMC3026LSD

Product Summary

Device	V _{(BR)DSS}	R _{DS(ON)} max	l _D max T _A = +25°C
Q1	Q1 30V	25mΩ @ V _{GS} = 10V	6.5A
QI	300	29mΩ @ V _{GS} = 4.5V	6.1A
00	2017	28mΩ @ V _{GS} = -10V	-6.2A
Q2	-30V	38mΩ @ V _{GS} = -4.5V	-5.3A

Description

This new generation MOSFET has been designed to minimize the onstate resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- DC-DC Converters
- Power Management Functions
- Backlighting

Features and Benefits

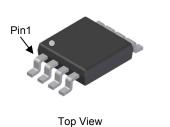
- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)

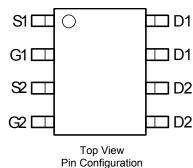
COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

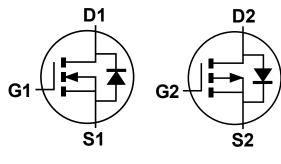
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Tin Finish annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.074 grams (approximate)







Equivalent Circuit

Ordering Information (Note 4)

Part Number	Case	Packaging
DMC3026LSD-13	SO-8	2,500/Tape & Reel

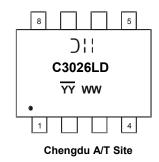
Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

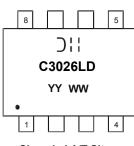
2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information





Shanghai A/T Site

 $\begin{array}{l} \bigcirc I \\ \hline \end{array} = Manufacturer's Marking \\ \hline C3026LD = Product Type Marking Code \\ \hline YYWW = Date Code Marking \\ \hline YY or \overrightarrow{YY} = Year (ex: 14 = 2014) \\ \hline WW = Week (01 - 53) \\ \hline \underline{YY} = Date Code Marking for SAT (Shanghai Assembly/ Test site) \\ \hline \overrightarrow{YY} = Date Code Marking for CAT (Chengdu Assembly/ Test site) \\ \hline \end{array}$



Maximum Ratings – Q1 and Q2 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Q1	Q2	Units		
Drain-Source Voltage	V _{DSS}	30 ±20	-30 ±20	V V		
Gate-Source Voltage	V _{GSS}					
	Steady	T _A = +25°C	I	6.5	-6.2	А
Continuous Drain Current (Note 6) V _{GS} = 10V	State	T _A = +70°C	ID	5.2	-5.0	
	t<10s	T _A = +25°C	I	8.2	-8.0	А
	1<105	T _A = +70°C	ID	6.7	-6.5	
Maximum Body Diode Forward Current (Note 6)		Is	2.2	-2.5	A	
Pulsed Drain Current (10µs pulse, duty cycle = 1	I _{DM}	40	-40	A		
Avalanche Current (Notes 7) L = 0.1mH	I _{AS}	14.5	22	A		
Avalanche Energy (Notes 7) L = 0.1mH	E _{AS}	10.5	25	mJ		

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units	
Tatal Dower Dissinction (Nata 5)	T _A = +25°C	D	1.2	W
Total Power Dissipation (Note 5)	T _A = +70°C	PD	0.8	
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	D	102	°C/W
memai resistance, sunction to Amblent (Note 5)	t<10s	$R_{\theta JA}$	62	
Total Power Dissipation (Note 6)	T _A = +25°C	Po	1.6	w
Total Power Dissipation (Note 6)	T _A = +70°C	PD	1.0	
Thermal Registeres, Junction to Ambient (Note 6)	Steady state	De	78	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	R _{0JA}	47	
Thermal Resistance, Junction to Case (Note 6)	Rejc	14.5		
Operating and Storage Temperature Range		T _{J,} T _{STG}	-55 to +150	°C

Electrical Characteristics – Q1 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)					•	•
Drain-Source Breakdown Voltage	BV _{DSS}	30	_	—	V	$V_{GS} = 0V, I_D = 250 \mu A$
Zero Gate Voltage Drain Current	I _{DSS}		_	1	μA	V _{DS} = 24V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	V _{GS(th)}	1	_	3	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance	P	_	19	25	mΩ	V _{GS} = 10V, I _D = 6A
	R _{DS (ON)}	_	22	29	1115.2	V _{GS} = 4.5V, I _D = 5A
Diode Forward Voltage	V _{SD}	_	0.7	1.2	V	V _{GS} = 0V, I _S = 1.3A
DYNAMIC CHARACTERISTICS (Note 9)				_		
Input Capacitance	C _{iss}		641	—		V _{DS} = 15V, V _{GS} = 0V f = 1.0MHz
Output Capacitance	C _{oss}		66	—	pF	
Reverse Transfer Capacitance	C _{rss}		51	_		
Gate Resistance	R _G	_	2.2	—	Ω	V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	6	—		
Total Gate Charge (V _{GS} = 10V)	Qg	_	13.2	—	nC	V _{DS} = 15V, I _D = 10A
Gate-Source Charge	Q _{gs}	_	1.7	—	110	VDS - 13V, 10 - 10A
Gate-Drain Charge	Q _{gd}		2.2	—		
Turn-On Delay Time	t _{D(on)}		3.3	—		
Turn-On Rise Time	tr		4.4	—	nS	V_{GS} = 10V, V_{DD} = 15V, R_{G} = 6 Ω ,
Turn-Off Delay Time	t _{D(off)}		22.3		113	I _D = 1A
Turn-Off Fall Time	t _f	_	5.3	_	1	

 Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
UIS in production with L = 0.1mH, starting T_A = +25°C.
Short duration pulse test used to minimize self-heating effect.
Guaranteed by design. Not subject to product testing. Notes:



Electrical Characteristics – Q2 (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Мах	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV _{DSS}	-30	—	—	V	$V_{GS} = 0V, I_D = -250 \mu A$	
Zero Gate Voltage Drain Current	I _{DSS}		—	-1	μA	V_{DS} = -24V, V_{GS} = 0V	
Gate-Source Leakage	I _{GSS}		—	±100	nA	V_{GS} = ±20V, V_{DS} = 0V	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V _{GS(th)}	-1	—	-3	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
Static Drain-Source On-Resistance	D	_	21	28	mΩ	V_{GS} = -10V, I_{D} = -6A	
Static Drain-Source On-Resistance	R _{DS(ON)}	_	29	38	1115.2	V_{GS} = -4.5V, I _D = -5A	
Diode Forward Voltage	V _{SD}	_	-0.7	-1.2	V	V _{GS} = 0V, I _S = -1.3A	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C _{iss}	_	1241	—	pF	V _{DS} = -15V, V _{GS} = 0V f = 1.0MHz	
Output Capacitance	C _{oss}		146	_			
Reverse Transfer Capacitance	C _{rss}	_	110	_			
Gate Resistance	R _G	_	14.8		Ω	V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz	
Total Gate Charge (V _{GS} = -4.5V)	Qg		10.9	_			
Total Gate Charge (V _{GS} = -10V)	Qg		22	_	nC	V _{DS} = -15V, I _D = -7A	
Gate-Source Charge	Q _{gs}	_	3.5		nc	VDS = -15V, 10 = -7A	
Gate-Drain Charge	Q _{gd}	_	4.7				
Turn-On Delay Time	t _{D(on)}	_	9.7	_		V _{GS} = -10V, V _{DD} = -15V, R _{GEN} = 60	
Turn-On Rise Time	tr	_	17.1	_	nS		
Turn-Off Delay Time	t _{D(off)}	_	60.5	_	113	I _D = -7A	
Turn-Off Fall Time	t _f		40.4		1		

 8. Short duration pulse test used to minimize self-heating effect.
9. Guaranteed by design. Not subject to product testing. Notes:



= 85°C

25°C

-55°C

3

T_A = 125°C

 $T_A = 25^{\circ}C$

20

V_{GS} = 4.5V

I_D = 5A

15

25

50

75

3.5

T_A = 150°C

T_A = 85°C

 $T_A = -55^{\circ}C$

25

V_{GS} = 10V I_D = 10A

125

100

30

4

2.5

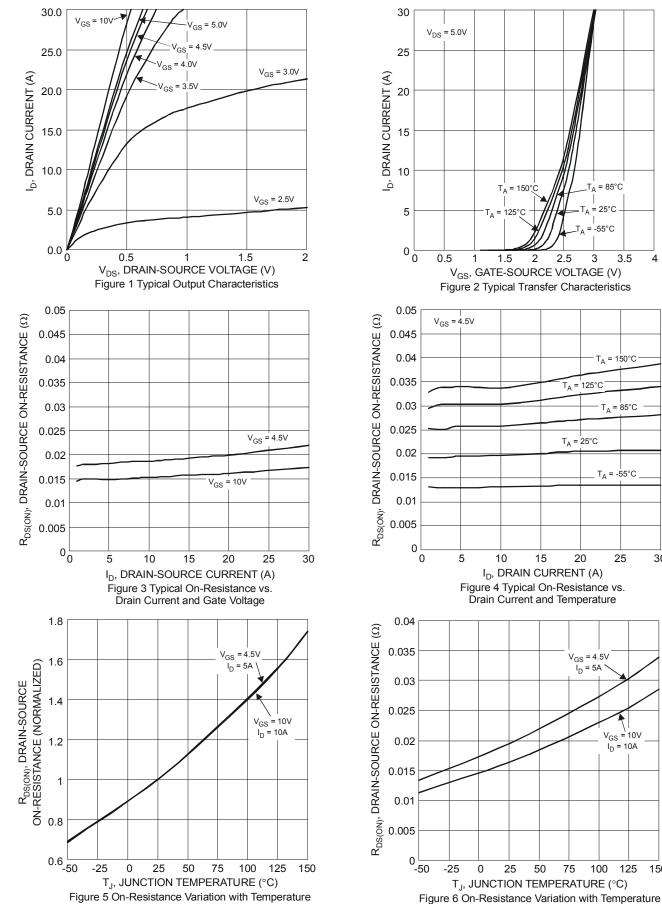
 $= 150^{\circ}$

2

125°C

T₄

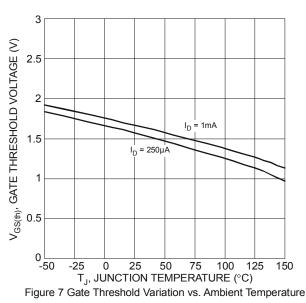
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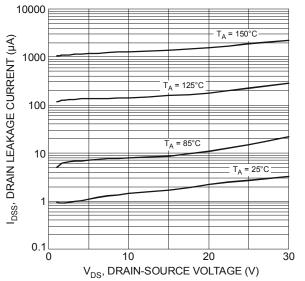
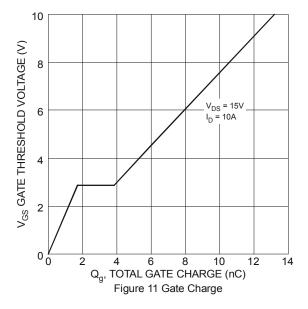
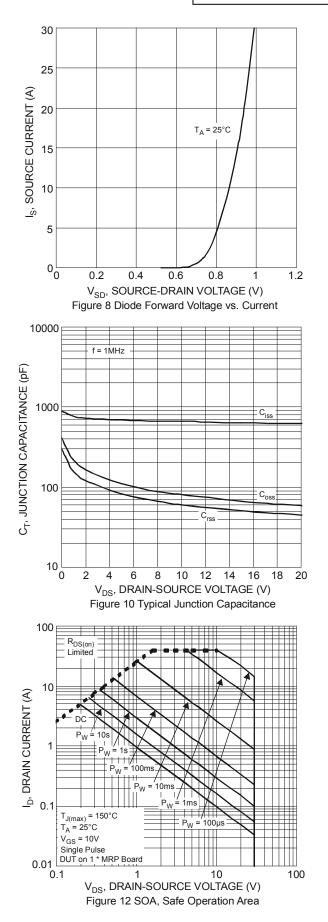


Figure 9 Typical Drain-Source Leakage Current vs. Voltage

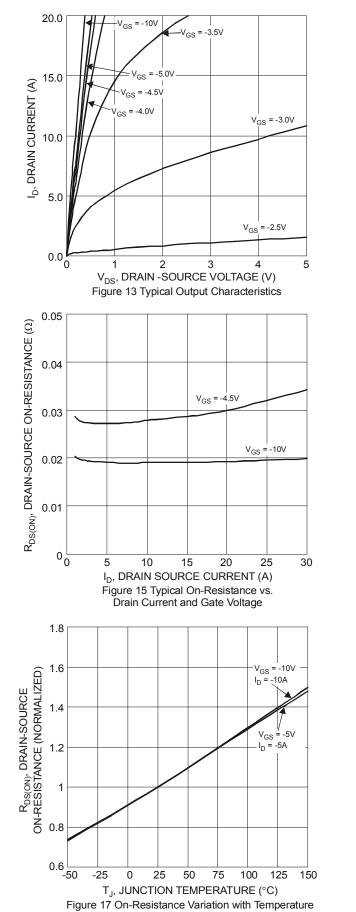


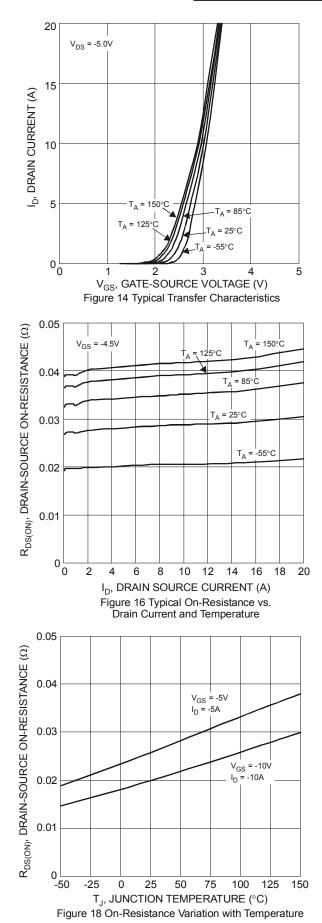




NEW PRODUCT

DMC3026LSD





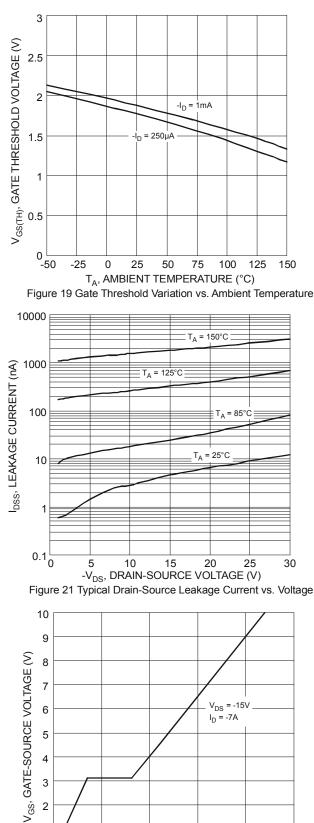
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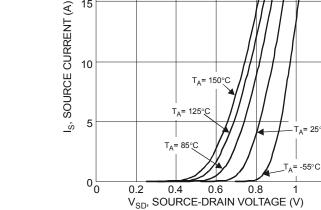


DMC3026LSD

1

1.2

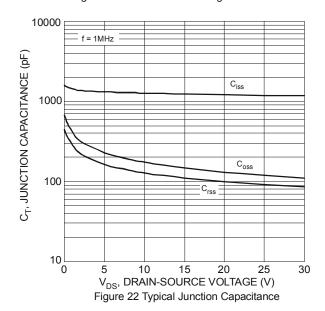


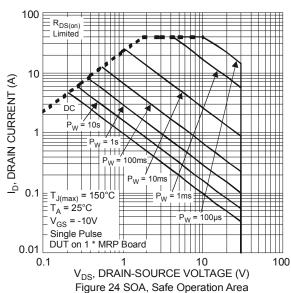


20

15

Figure 20 Diode Forward Voltage vs. Current





NEW PRODUCT

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5

10

Q_a, TOTAL GATE CHARGE (nC)

Figure 23 Gate-Charge Characteristics

15

20

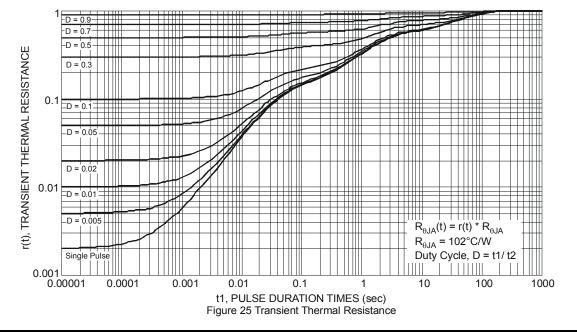
25

1

0

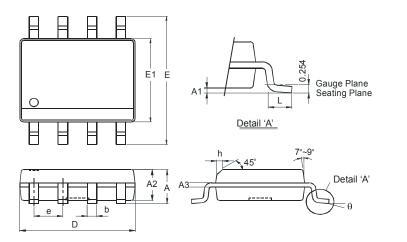
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Package Outline Dimensions

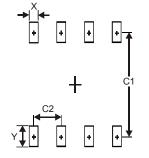
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



	SO-8						
Dim	Min	Max					
Α	-	1.75					
A1	0.10	0.20					
A2	1.30	1.50					
A3	0.15	0.25					
b	0.3 0.5						
D	4.85	4.95					
Е	5.90 6.10						
E1	3.85 3.95						
е	e 1.27 Typ						
h	-	0.35					
L	0.62	0.82					
θ	0°	8°					
All Di	All Dimensions in mm						

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Х	0.60
Y	1.55
C1	5.4
C2	1.27

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